N-Channel Enhancement-Mode Transistors

Characteristics

- N-channel Vertical DMOS
- Macro-Model (Subcircuit)
- Level 3 MOS
- Applicable for Both Linear and Switch Mode

- Applicable Over a -55 to 125°C Temperature Range
- Models Gate Charge, Transient, and Diode Reverse Recovery Characteristics

Description

The attached SPICE Model describes typical electrical characteristics of the n-channel vertical DMOS. The subcircuit model was extracted and optimized over a 25°C to 125°C temperature range under pulse conditions for 0 to 10 volt gate drives. Saturated output impedance model accuracy has been maximized for gate biases near threshold. A novel gate-to-drain feedback capacitance network is used to model gate charge characteristics while avoiding convergence problems of switched C_{gd} model. Model parameter values are optimized to provide a best fit to measured electrical data and are not intended as an exact physical description of a device.

Model Subcircuit
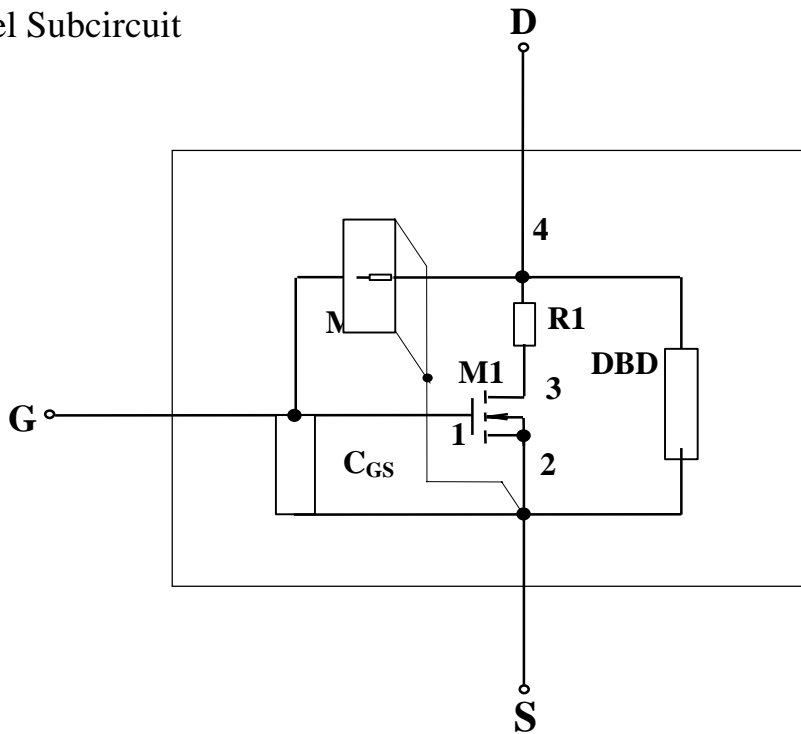
This document is intended as a SPICE modeling guideline and does not constitute a commercial product data sheet. Designers should refer to the appropriate data sheet of the same number for guaranteed specification limits.

Model Evaluation

N-Channel Device (T_J=25°C Unless Otherwise Noted)

Parameter	Symbol	Test Conditions	Typ	Unit
Static				
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	**3.12**	V
On-State Drain Current[b]	$I_{D(on)}$	$V_{DS} = 5V$, $V_{GS} = 10V$	**416**	A
Drain-Source On-State Resistance[b]	$r_{DS(on)}$	$V_{GS} = 10V$, $I_D = 30A$	**0.011**	Ω
		$V_{GS} = 10V$, $I_D = 30A$, $T_J = 125°C$	**0.018**	
		$V_{GS} = 10V$, $I_D = 30A$, $T_J = 175°C$	**0.022**	
Forward Transconductance[b]	g_{fs}	$V_{DS} = 15V$, $I_D = 30A$	**60**	S
Forward Voltage[b]	V_{SD}	$I_F = 75A$, $V_{GS} = 0V$	**0.92**	V
Dynamic[a]				
Input Capacitance	C_{iss}	$V_{GS} = 0V$, $V_{DS} = 25V$, $f = 1MHz$	**4890**	pF
Output Capacitance	C_{oss}		**963**	
Reverse Transfer Capacitance	C_{rss}		**221**	
Total Gate Charge[c]	Q_g	$V_{DS} = 30V$, $V_{GS} = 10V$, $I_D = 75A$	**83**	nC
Gate-Source Charge [c]	Q_{gs}		**31**	
Gate-Drain Charge[c]	Q_{gd}		**24**	
Turn-On Delay Time[c]	$t_{d(on)}$	$V_{DD} = 30V$, $R_L = 0.47\Omega$ $I_D \cong 75A$, $V_{GEN} = 10V$, $R_G = 2.5\Omega$	**57**	ns
Rise Time[c]	t_r		**31**	
Turn-Off Delay Time[c]	$t_{d(off)}$		**62**	
Fall Time[c]	t_f		**20**	
Reverse Recovery Time	t_{rr}	$I_F = 75A$, di/dt =100A/μs	**100**	ns

Notes:

a) Guaranteed by design, not subject to production testing

b) Pulse test: pulse width ≤ 300 μsec, duty cycle ≤ 2%

c) Independent of operating temperature

Comparison of Model with Measured Data
 (T$_J$=25°C Unless Otherwise Noted)